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4	Easy-to-Compute Response Times Based Statistics for Detecting Aberrant Behaviors of
5	Test-takers
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Abstract

2	In this study, we develop an easy-to-compute statistic for detecting examinees'
3	aberrant response times in large-scale computer-based assessments. Using this statistic,
4	a response time is flagged as aberrant when it is longer or shorter than expected. The
5	flagged response times are summarized to indicate examinees' abnormal test behaviors,
6	such as pre-knowledge, rapid guessing and item memorization. A simulation study was
7	conducted to evaluate this method's performance in various conditions. Results showed
8	that the proposed statistic approximately followed a normal distribution in the null
9	condition, performed equivalently well to van der Linden & Guo's (2008) Bayesian
10	procedure in detecting aberrant response times, and reduced computational burden
11	monumentally. A high-stake educational assessment was used to illustrate its
12	application.

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Key words: test security breach, response times, abnormal test behavior

1	Easy-to-Compute Response Times Based Statistics for Detecting Aberrant Behaviors of
2	Test-takers
3	Introduction
4	A breach to test security may have serious implications for the psychometric integrity of
5	the reported test scores and on the interpretations and consequences of those scores
6	(Standards for Educational and Psychological Testing, 2014; p. 225). Statistical methods
7	developed for test security purposes have become increasingly popular (Drasgow,
8	Levine & Williams, 1985; Reise & Due, 1991; Impara et al., 2005; van der Linden & Guo,
9	2008; Marianti & et al., 2014; Li & Smith, 2015; Fox & Marianti, 2017). So far, statistical
10	methods based on examinees' responses are the most studied, such as erasure analysis
11	indices, answer copying indices and person fit indices. Applying statistical methods for
12	test security purposes provides methods that are highly efficient but low cost, as they
13	serve as a screening tool before more expensive investigations are conducted.
14	Compared to item responses, the study of response times is relatively new. According
15	to recent research, response times can provide valuable information for improving test
16	development, test security, as well as score use and interpretability. For example, Wise
17	& Kong (2015) studied examinees' engagement during tests based on response time
18	patterns. Fox & Marianti (2016) explore the relationship between response speed and
19	accuracy. It is well known that traditional person fit indices examine the congruence
20	between an item response pattern and a specified item response theory model (Reise &

Due, 1991). Similarly, aberrant test behaviors can be identified by comparing expected 1 response times and observed response times. Recently, using latent variable modeling 2 of response times, several methods have been developed for detecting aberrance in 3 response time patterns (van der Linden & Guo, 2008; van der Linden, 2009). However, 4 5 these methods have the shortcomings of being highly complex to implement and 6 computationally ineffective. The purpose of this study is to develop easy-to-compute 7 statistics for detecting aberrant response time patterns in large-scale assessments. 8 The practical value of the three proposed statistics are illustrated and expanded in the 9 paper. So far, no adequate approach has been developed to detect aberrant response time patterns during testing. Most of the current methods remain in the psychometric 10 11 lab and are not widely used in practice. Either the field needs to develop new software to implement the more complex procedures based on response time models, or develop 12 13 an easy-to-compute index, so that existing testing software can employ these methods without additional effort. 14 Data Forensic Methods and Response Time Modeling 15 16 Post-hoc data analysis for test security purposes has long existed. Early studies focused 17 on the similarities between paired examinees' answers, indices of answer copying, and 18 the likelihood of test-takers' responses with well-known test theory models. 19 Nonetheless, test security breaches remain a significant issue in large-scale assessments

20 since many existing statistical methods are only based on examinees' responses and a

1	large number are highly complex. Recently, with the popularity of computer-based
2	assessments, more information can be captured during the testing process. Therefore,
3	new statistics have been proposed for this purpose.
4	Early studies focused on developing statistics used for detecting aberrant item response
5	patterns, which are commonly known as person-fit indices (Reise & Due, 1991). The
6	shift to computer-based testing allows examinees' response times to be easily recorded,
7	however, and the response time data can be used for test security analyses. van der
8	Linden & Guo (2008) proposed a Bayesian procedure to identify aberrant response time
9	patterns, specifically those indicating pre-knowledge and item memorization in
10	adaptive testing. Their method was based on a hierarchical latent response time model.
11	In their first step, latent variables and item parameters are estimated based on a set of
12	real data using Monte-Carlo Markov-Chain (MCMC). In the second step, the posterior
13	distribution of each test-taker's response time is calculated. In the third step, the
14	observed response time for each test-taker on each item is compared with the posterior
15	distribution. A p value is computed, assuming that the posterior distribution is log-
16	normal.
17	Qian et al. (2016) applied the Bayesian procedure to detect item pre-knowledge and
18	potentially compromised items in two computer-based large-scale licensure

19 examinations. The results indicated this procedure was helpful in monitoring aberrant

1	examinee behaviors, as well as enhancing future item writing. However, this is the only
2	publication that could be found applying the Bayesian procedure.
3	Marianti & et al. (2014) developed another set of statistics for detecting aberrant test
4	behaviors based on the lognormal response time model. The statistics were derived
5	from the well-known person fit statistic l_z (Reise & Due, 1991). The log likelihoods of
6	the response time patterns were used to evaluate the fit of a response time pattern to a
7	specified model. Furthermore, Fox & Marianti (2017) developed a person fit index with
8	a hierarchical response time model, taking into consideration both response time and
9	response accuracy. Additionally, Wang & Gong (2015) proposed a hierarchical mixture
10	response time model for detecting examinees' engagement during testing, however this
11	may be harmful to test validity. All these methods have their own merits in different
12	ways. Nonetheless, the complexity of the methods based on latent variable modeling
13	constrain them from being widely used in practice. Additionally, these methods are
14	often computationally demanding.
15	Response Time Models
16	Using response time to explore and interpret test-takers' testing behaviors and
17	outcomes is not necessarily a new approach. Thissen (1983) developed an extended item
18	response theory model, taking into account person speed and ability simultaneously.
19	Wang & Hansen (2005) developed a four-parameter logistic response time model,
20	incorporating response time information to predict the probability of answering an item

correctly. With these models, however, the aberrance of response time patterns is not
 known.

One of the popular response time models is van der Linden's (2006) lognormal model.
The model assumes that test-takers' speed remains constant during testing, and that
examinees answer each item independently. It contains three latent variables: *τ_j*represents the speed of test taker j, *β_i* is the time intensity of item i, and *α_i* is a
discrimination parameter. This model is often presented as a lognormal density for the
distribution of test-takers' response times (*RT_{ij}*):

$$f(RT_{ij};\tau_j,\alpha_i,\beta_i) = \frac{\alpha_i}{RT_{ij}\sqrt{2\pi}} e^{\{-\frac{1}{2}[\alpha_i(\log_{RT_{ij}}-(\beta_i-\tau_j))]^2\}}.$$
(1)

9 The advantages of this model include that, when it is combined with an item response
10 model, a hierarchical response time model is formed. Not only could we study the
11 relationship among latent variables, the information from response times might also be
12 used for improving item calibration and test scoring.

van der Linden and other researchers have applied the above-mentioned response time
model in many aspects. For example, van der Linden & Guo (2008) applied the
hierarchical lognormal response time model for detecting aberrant test-takers' aberrant
test behaviors in computer adaptive testing (CAT); van der Linden (2009) proposed
another bivariate lognormal response time model for the detection of collusion between
test-takers. van der Linden (2008) used this model to improve the accuracy of item
selection in a CAT design.

1	As mentioned above, the idea of detecting aberrant test behaviors is not new. Any
2	differences between the expected response pattern and the observed response pattern
3	or the expected response time pattern and the observed response time pattern could
4	imply an aberrant test behavior. The difficulty comes from how we detect the
5	aberrances efficiently and accurately. Although van der Linden and Guo's (2008)
6	Bayesian estimation can provide relative accurate latent variable estimates, the
7	estimation process is computationally demanding. In the following section a simplified
8	approach is proposed for detecting test-takers' aberrant behavior. Not only is this
9	approach easy to implement in any testing software, it requires much less computation.
10	The Proposed Statistics
11	Basic Summative Statistics and the Indicator of Aberrance

Suppose there are *N* examinees and *n* items. The response time of examinee *j* to item *i* is indicated by RT_{ij} . First, the average response time to item *i* is indicated by $\overline{RT_{i,j}}$, which is

$$\overline{RT_{i.}} = \frac{\sum_{1}^{N} RT_{ij}}{N}.$$
(2)

Furthermore, the total test time of examinee *j* is indicated by $RT_j = \sum_{i=1}^{n} RT_{ij}$. The average total test time among *N* examinees is:

$$\overline{RT_j} = \frac{\sum_{1}^{N} RT_j}{N} = \sum_{1}^{n} \overline{RT_{L}},$$
(3)

- 1 which is also equal to the sum of the average response time on each item. Thereby, the
- 2 expected response time for examinee *j* on item *i* could simply be the average response

3 time across all persons and all items:
$$R\widehat{T}_{ij} = \overline{RT_j}/n$$
.

4 An aberrance indicator is defined as the difference between the observed response time

5 RT_{ij} and the expected value \widehat{RT}_{ij} :

$$Aberrance = (RT_{ij} - R\widehat{T}_{ij}).$$
(4)

6 Statistic I: Standardized Aberrance

Assuming that examinees' response time to each item follows a normal distribution, the
simplest statistic for detecting aberrant response times can be obtained by standardizing
the index of aberrance in equation 4:

$$Z_0 = \frac{RT_{ij} - R\widehat{T}_{ij}}{S.D.(RT_{i.})}.$$
(5)

10 Z_0 will be used as a baseline for index comparison. It is conjectured that it won't work

- 11 well, as response times don't often follow a normal distribution.
- 12 Statistic II: Standardized the Aberrance using Logarithm of Response Times

13 It is commonly shown that students' response times follow a log-normal distribution.

- 14 Therefore, we take the logarithm of the response time matrix, and compute a
- 15 standardized residual index like this:

$$Z_l = \frac{\log \left(RT_{ij}\right) - \log \left(R\overline{T}_{ij}\right)}{S.D.\left(\log \left(RT_{i}\right)\right)}.$$
(6)

Notice that both Z_0 and Z_l have a strong assumption that all test-takers have an equal 1 speed during testing. This assumption can often be violated in the real world. Following 2 the idea of a standardized response time, a relative standardized response time is 3 proposed. This new statistic considers person speed in the computation. 4 5 Statistic III: Standardized Logarithm Aberrance with Person Speed Van der Linden (2006, 2009, 2011) defined person speed as latent variables in his 6 lognormal RT model. As we know, person speed is defined as the item's time loading 7 divided by response times on the item: $\tau_j = \frac{\beta_i}{\log (RT_{ij})}$, where τ_j is assumed to be constant 8 across all items. 9 The definition of person speed used here follows the same structure. However, instead 10 11 of using the latent variables, simple summative statistics are used. Assuming that person speed is a constant parameter across all items. Examinees' speed is quantified as 12

$$Speed_j = \frac{\overline{RT_j}}{RT_j}.$$
(7)

The longer the time an examinee takes for a test, the lower the speed is. With speed computed, the expected response time of examinee *j* to item *i* is obtained, which is the average response time on item *i* divided by person speed:

the average total test time divided by the total test time of examinee *j*:

$$\widehat{RT}_{ij} = \frac{\overline{RT_{i.}}}{Speed_j}.$$
(8)

Similarly, when the response times are transferred onto the logarithmic scale, person
speed can be calculated by log(*RT_J*) - log(*RT_j*). Furthermore, considering random
errors reflected in the variances of response times on each item, person speed is
calculated by the weighted average response time residual:

$$speed_{j} = \frac{\sum_{i=1}^{n} \frac{(\overline{\log(RT_{i})} - \log(RT_{ij}))}{var(logRT_{i})}}{\sum_{i=1}^{n} \frac{1}{var(logRT_{i})}}.$$
(9)

5 The expected value of $log(RT_{ij})$ after adjusting for person speed is $(\overline{log(RT_i)} - speed_j)$.

6 The variance of $log(RT_{ij})$ is the total variance minus the group (person) variance:

$$var(logRT_i) - var(speed_j).$$
 (10)

7 Thereby, the standardized value of aberrance taking into consideration person speed8 variance is as follows:

$$Z_{s} = \frac{\log(RT_{ij}) - (\overline{\log(RT_{i})} - speed_{j})}{\sqrt{var(logRT_{i}) - var(speed_{j})}}.$$
(11)

9 In the following two sections, we use a simulation study and an empirical study to

10 examine the performance of these three proposed statistics.

1	of compromised items, sample size, test length, as well as the population aberrance
2	rates, might have an influence on the performance of these statistics. The effects of the
3	four factors were examined in this study.
4	Simulation Design
5	Four factors were considered in the simulation study. Sample size and number of items
6	in the test were considered because both are critical features of any assessment. A pilot
7	study showed that the proposed statistic performed equivalently well in various
8	conditions of sample sizes (500, 1000, 10000). Therefore, in the current simulation study,
9	only the small sample size (N =500) condition was considered. Additionally, the
10	aberrance rates of items (proportion of compromised items), and the aberrance rates in
11	the sample (proportion of test-takers who have aberrant test behaviors) were
12	considered based on previous research (Marianti & et al., 2014). The details of these
13	factors are listed in Table 1.
14	Data Generation
15	1) Generating observed response times
16	Response times were generated based on a lognormal model (van der Linden, 2006):
	$\log (RT_{ij}) = \beta_i - \tau_j + \varepsilon_{ij} , \qquad \varepsilon_{ij} \sim N(0, 1/\alpha_i^2) $ (12)
17	where β_i , τ_j , and α_i were obtained from empirical data analysis. The longest response
18	time for an item is constrained to be 20 minutes, and the shortest response time on one

19 item is constrained to be 1 second, according to students' observed response times for

1	multiple choice items in state assessments. Outliers, e.g., an extremely long response
2	time or short response time, were not a factor of interest, therefore were not simulated
3	in the current study.
4	2) Generating aberrant response times
5	Aberrant RTs were generated by three steps. First, a proportion of items were chosen
6	according to the factor ARI in the simulation design. Second, a proportion of examinees
7	were randomly selected from the sample according to the factor ARS in the simulation
8	design. Third, with true person parameters and item parameters, the lognormal
9	distribution of response times for the selected person on the chosen item was known.
10	An aberrant RT is generated by taking a value of the cut points which are located at
11	three standard deviations from the mean (half negative and half positive).
12	Statistics of Interest
13	The proposed three easy-to-compute statistics (Z_0 , Z_l , Z_s) are of major interest in this
14	study. In addition, two statistics based on van der Linden's (2006) lognormal response
15	time model are computed for comparison.
16	After fitting the generated response time matrix with the lognormal model, parameter
17	estimates $\hat{\beta}_{\iota}$, $\hat{\alpha}_{\iota}$ and $\hat{\tau}_{j}$ can be obtained. Assuming that these parameter estimates were
18	the true parameters, the expected response time for examinee <i>j</i> on item <i>i</i> is $(\hat{\beta}_i - \hat{\tau}_j)$, and
19	the variance of response times on this item as $(1/(\hat{\alpha}_{l})^{2})$. A standardized residual index
20	for detecting aberrance will be the fourth statistical index:

$$Z_m = \frac{\log \left(RT_{ij}\right) - \left(\widehat{\beta}_i - \widehat{\tau}_j\right)}{1/_{\widehat{\alpha}_i}}.$$
(13)

1 The reason for introducing Z_m is that it has the same structure as the proposed statistic Z_s . The only difference is that Z_m uses parameters estimated from latent variable 2 modeling for persons' speed and items' time loadings. 3 4 The other statistic is a posterior predictive checking method, taking into consideration the posterior distribution of the person speed parameters. This method was first 5 6 introduced by van der Linden & Guo (2008), known as a Bayesian procedure. Based on the posterior distribution of response time of person *j* on item *i*, the *p* values and 7 8 standardized residuals were calculated by comparing the observed response time to this posterior distribution. 9 These two indices are comparable to the proposed easy-to-compute statistics above, as 10 both of them follow a standard normal distribution. The difference lies in whether the 11 12 estimated parameters from latent variable modeling or the observed response times are used directly to approximate the expected response times. 13 **Evaluation** Criteria 14 15 To determine whether a response time pattern is aberrant, the five statistics are 16 calculated for each observed response time. RTs with extreme values will be flagged if the statistic is higher than 1.96 or lower than -1.96. After this process, each examinee 17 18 will have or not have several flagged RTs. The proportion of flagged RTs of an

1 examinee is computed. This number is then compared with a designated cut (varies

- 2 with total number of items, see attachment). The power of the statistics is compared
- 3 with respect to the following criteria:

4 Probability of detection: proportion of examinees flagged with aberrant RT patterns,

5 among the actual number of examinees with true aberrant RT patterns (as designed in

6 data generation). It is often regarded as a sensitivity index in statistics:

$$Detection \ rate = \frac{N * P_{true \ positive}}{N * (P_{true \ positive} + P_{false \ negative})},$$
(14)

Precision of detection: Proportion of examinees with true aberrant RT patterns, among
the number of examinees flagged as having an aberrant RT pattern. The equation is as
following:

$$Precision of Detection = \frac{N * P_{true \ positive}}{N * (P_{true \ positive} + P_{false \ positive})}.$$
(15)

- 10 Results of Simulation Study
- 11 1) Type I error

12 In the null conditions, the asymptotic distributions of the proposed statistics are

13 examined. As the statistics follow a standard normal distribution, when the α level was

set to be 0.025 on each side, the empirical rejection rates at both sides should be close to

15 0.025.

- In Table 2, the empirical rejection rates for Z_l and Z_s approximate 0.025 on both the left
- side ($\alpha = -0.025$) and the right side ($\alpha = 0.025$). However, the empirical rejection rates

1	for Z_0 were not close to 0.025 on both sides. The large value of empirical rejection rates
2	on the right side shows that the distribution of Z_0 was positively skewed.
3	In addition, flagging rules for individuals were used to check how likely an individual
4	with no aberrance will be falsely flagged by the statistics. Results in Table 2 show that
5	Z_s has zero probability of randomly flagging any examinee when no aberrant response
6	time pattern exists. On the contrary, both Z_0 and Z_l flagged 6%-11% examinees
7	incorrectly by chance.
8	2) Power
9	The power of the proposed statistics was tested in various alternative conditions, where
10	aberrant response times were generated. The probability of detection (P.d.) and
11	precision of detection (P) of statistics Z_0 , Z_l and Z_s were compared with van der Linden
12	& Guo's (2008) Bayesian procedure and Z_m .
13	From Table 3, it is obvious that Z_s performed better than Z_0 and Z_l . It had a higher
14	precision of detection in all the conditions, and had a higher probability of detection in
15	most conditions. When the number of items were small (n=20), and the proportion of
16	compromised items was low (10%), which meant that only 2 items were compromised
17	in the test, all statistics had very low (<= 0.08) probability of detection. However, the
18	precision of detection for Z_s was much higher than those of Z_0 and Z_l . As the number of
19	items increased and the proportion of compromised items increased, both the detection
20	rates and precision of detection for Z_s grew. For example, when the number of items

1	was 70, aberrance rates in the sample were 0.05, and the proportion of compromised
2	items was 25%, the detection rate grew to 97%, and the detection precision grew to 98%.
3	Furthermore, compared to the two approaches based on latent variable modeling (van
4	der Linden and Guo's Bayesian procedures and Z_m), Z_s performed equivalently well in
5	all the conditions we tested. The detection rates and precision of detection of the
6	proposed new statistic were close to those of van der Linden and Guo's (2008) Bayesian
7	procedure. In the following section, some factors are discussed that exert an influence
8	on the performance of the proposed statistic.
9	3) The Influence of Factors
10	To better illustrate how each of the statistics' performance were influenced by the three
11	factors: the proportion of compromised items, test length and the proportion of
12	examinees with aberrant response times, the following figures are displayed.
13	Figure 1 shows the influence of aberrance rates of items on the probability of detection
14	and precision when the number of items was increased from 20 to 70. The aberrance
15	rate in the sample was fixed to 10%. When the percentage of compromised items was
16	10%, all five indices had low probability of detection. However, when the percentage of
17	compromised items increased from 10% to 25%, three of the indices' probability of
18	detecting aberrant response time patterns improved adequately for the short test (n=20),
19	and improved rapidly for longer tests (n=40 and n=70). Z_m had the highest probability
20	of detection in the tested conditions, while Z_s and the Bayesian procedure followed very

closely. As a comparison, Z₀ and Z_l didn't improve significantly when the percentage of
 compromised items increased.

3	The bottom three plots in Figure 1 show that, Z_s , the Bayesian procedure and Z_m also
4	performed similarly with respect to precision of detection in various conditions. When
5	the aberrance rates of items increased to 25%, the precision of detection improved
6	rapidly for the short test (n=20). For longer tests, the precision of these three detection
7	indices was high even if the aberrance rate of items was low (10%), therefore the
8	increased rates were small. When the aberrance rate of items reached 25%, no matter
9	how many items there were, their precision of detection was close to 1. On the contrary,
10	Z_0 and Z_l had very low precision of detection across all condition levels, with slight
11	improvement when the aberrance rates of items increased to 25%.
12	Figure 2 shows the influence of aberrance rates of sample on the probability and
13	precision of detection. The top plots in Figure 2 show that when the aberrance rates of
14	sample increased from 5% to 10%, the three statistics with high detection rates (Z_s ,
15	Bayesian procedure, and Z_m) had lower probabilities of detecting aberrant response
16	time patterns. The other two statistics (Z_0 and Z_l) had equivalently low probability of
17	detection in both conditions. On the contrary, the bottom three plots of Figure 2 show
18	that with the increased aberrance rate in the sample, all statistics' precision of detection
19	improved slightly.

1	Both Figure 1 and Figure 2 show the influence of test length on the performance of the
2	statistics: with the increased total number of items, the probability and precision of
3	detection improved for all statistics. In particular, the precision of detection increased to
4	almost 1 with a test length of 70, even if the percentages of compromised items and the
5	percentages of aberrant examinees were relatively small.
6	4) Summary
7	A simulation study was carried out to evaluate the performance of the proposed
8	statistics compared to an existing Bayesian procedure (van der Linden & Guo, 2008). In
9	the null condition, two of the three new statistics, Z_l and Z_s , approximately follow a
10	standard normal distribution. The simplest statistic Z_0 turns out to be extremely skewed
11	to the right. Specifically, the left-tail p values were close to 0, while the right-tail p
12	values approximated 0.05.
13	A most interesting finding was that, compared with the two procedures based on latent
14	variable modeling, Z_s performed equivalently well in detecting response time
15	aberrance. Among the proposed easy-to-compute statistics, Z_s performed much better
16	than Z_0 and Z_l . Not only did it have higher precision of detection in all the simulation
17	conditions, it also had a higher probability of detection in most conditions.
18	Moreover, several factors, especially the aberrance rates in the sample and the
19	proportion of compromised items, exerted a significant influence on the performance of
20	the proposed statistics. The more compromised items the test had, the less the

1	examinees with aberrant response time patterns, the more likely that an aberrant
2	response time pattern could be detected (high probability of detection). However, the
3	precision of detection increased with both the number of compromised items and the
4	proportion of examinees with aberrant response time patterns.
5	It was also found that the compromised items will always have more aberrant RTs than
6	the other non-compromised items. In other words, based on the aberrance flagging of
7	RTs, the compromised items were flagged correctly.
8	Empirical Study
9	Examinees' response times in a computer-based Math test consisting of 58 items were
10	analyzed to illustrate the application of the proposed statistics. This test was part of a K-
11	12 state testing program from the 2016-17 school year. The sample included 6,827 Grade
12	6 students. Demographically, the sample was diverse. Results from the real data
13	analysis are discussed below.
14	We found that examinees' response times to most items approximately follow a
15	lognormal distribution. One item was removed from analysis as its response time did
16	not fit the lognormal distribution. The QQ-plot in Figure 3 shows that the total response
17	time on the remaining 57 items was well approximated by a lognormal distribution,
18	even though the slightly uplifted right tail indicated this distribution was a little heavy
19	tailed.

1	Next, we computed the proposed statistics, as well as statistics based on Guo and van
2	der Linden (2008)'s Bayesian procedure. Only a small proportion of aberrant response
3	time patterns were detected (Table 4). With a close look at these aberrant response time
4	patterns, possible reasons of the detected aberrance include speededness towards the
5	end, time management strategies, and rapid guessing. For example, one examinee spent
6	1-5 seconds through all 57 items, which indicates a rapid guessing behavior. It appeared
7	that no test-taker was engaged in any potential cheating behavior during testing.
8	Results in Table 4 show that about 5% of the examinees' response times were flagged by
9	our statistic of interest (Z_s). According to the property of standard normal distribution,
10	this probability is very close to the significance level 0.05. This finding indicates that no
11	significant aberrance was found in the empirical data set. In addition, it was noticed
12	that more positive response times were flagged than the negative response times by Z_0
13	statistic, which further proved a positively skewed distribution of response times. For
14	$Z_{\rm l}, Z_{\rm s}$, and the Bayesian procedure, the difference between positive and negative
15	flagging decreased to a small amount. Moreover, the extent to which two statistics flag
16	the same examinee's response time pattern was checked.
17	In Table 5, we found that, among the flagged individuals, more than 88% were flagged
18	simultaneously by Z_s and the Bayesian procedure, even if none of the examinees were
19	identified with cheating behaviors. It is very likely that, when real aberrant response

1	times exist, Z_s could be used to detect the aberrance as accurately as the Bayesian
2	procedure, which was also proved in the simulation study.
3	Additionally, the percentages of flagged examinees by each statistic in each school were
4	computed. Schools were flagged when the percentage of aberrant examinees was higher
5	than the state-level percentage (bottom row in Table 4). Results show that 23%, 29%,
6	26%, 27% and 26% schools were flagged by Index Z_0 , Z_l , Z_s , Bayesian procedure, and Z_m
7	respectively. Specifically, 96% of 596 schools in the state were simultaneously flagged
8	by both Z_s and the Bayesian procedure. Meanwhile, only 63% of schools in the studied
9	state were flagged by both Z_0 and the Bayesian procedure at the same time.
10	Furthermore, the criterion of flagging a school should be higher than the state-level
11	average rate in practice. When the flagging cut increased to 0.2, 99% of schools were
12	flagged by both Z_s and the Bayesian procedure at the same time.
13	Discussion
14	Results from the simulation study demonstrated that the proposed easy-to-compute Z_s
15	statistic performed well in null and alternative conditions. Specifically, in the conditions
16	tested, Z_s had similar probability and precision of detecting aberrant response time
17	patterns as van der Linden & Guo's (2008) Bayesian procedure. On the contrary, the
18	other two simpler statistics proposed in this paper (Z_0 and Z_1) do not have adequate
19	power in detecting aberrant response times. Furthermore, it was shown that test

1	lengths, proportion of aberrant examinees in the sample, as well as the number of
2	compromised items all exert an influence on the performance of the indices.
3	van der Linden & Guo (2008) argued that the Bayesian procedure accounts for the
4	presence of estimation error in any of the parameters of the psychometric model (e.g.,
5	ability parameters). Our method, on the other hand, eliminated any estimation error
6	because no latent variable needs to be estimated. Moreover, we noticed that the
7	Bayesian procedure had a slightly higher probability of detection than Z_m , which is also
8	based on the lognormal response time model. However, the probability and precision of
9	detection of Z_s are always close to van der Linden & Guo's (2008) Bayesian procedure.
10	Another important finding was that, when the test was short (20 items) and the
11	proportion of compromised items was low, all the statistics had a low probability of
12	detecting aberrant response time patterns. The precision of detection was lower or equal
13	to 54%. Therefore, it is recommended that no individual-level detection should be
14	carried out in this situation. Only when the test length is adequate (40 items), are the
15	detection results by the proposed Z_s statistic sufficiently reliable.
16	Additionally, empirical data analysis showed that Z_s could flag a large proportion of
17	examinees flagged as aberrance by the Bayesian procedure. When the statistics were
18	aggregated at the school level, Z_s and the Bayesian procedure almost flagged the same
19	schools even if the aberrance rates were very low in the real data. This finding provided
20	further evidence that Z_s would be a useful and powerful statistic in practice.

1	This study has its limitations. First, the data for the simulation study was generated
2	with a lognormal response time model. This doesn't take into consideration all the
3	features of a real response time data set. For example, test-takers' response time on one
4	item might not follow a lognormal distribution and their response speed might vary
5	during testing. Secondly, only one set of empirical data set was used to illustrate the
6	new statistics. This limits the number of types of aberrant test behaviors we detected in
7	this study. The performance of the proposed statistics need to be examined in more
8	situations. Furthermore, future study should consider improving the current data
9	forensic methods by incorporating more information sources, detecting aberrant
10	examinee behaviors using item response, response time and answer changing patterns.
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Appendix

- 2 Table 1
- 3 Simulation Study Design

Factors	Conditions
Sample size (N)	500
Number of items (n)	20, 40, 70
Aberrance rates of items (ARI)	5%, 10%
Aberrance rates in sample (ARS)	10%, 25%
*The factors are fully crossed in a $1 \times 3 \times 2 \times 2$	< 2 design with 500 replications in each

5 condition.

4

6 Table 2

7 *Type I error rates and the probability of false alarm*

n	Z_0				Z_l		Z_s		
11	$\alpha_{-0.025}$	$\alpha_{0.025}$	R _{flagged}	$\alpha_{-0.025}$	$\alpha_{0.025}$	R _{flagged}	$\alpha_{-0.025}$	$\alpha_{0.025}$	<i>R_{flagged}</i>
20	.000	.053	.08	.023	.023	.06	.026	.024	.00
40	.000	.052	.09	.029	.021	.09	.026	.024	.00
70	.000	.052	.11	.027	.022	.10	.026	.024	.00
70	.000	.002	.11	.027	.022	.10	.020	.024	.00

11

10

8

1 Table 3

2 Statistical power at individual level

	A.R.	Proposed Simple Statistics						Latent Model Statistics				
n	in of	Z_0		Ζ	Z_l		Z_s		Bayes		Z_m	
	Sample	Items	P.d.	Р	P.d.	Р	P.d.	Р	P.d.	Р	P.d.	Р
	OF	.10	.08	.06	.08	.06	.05	.49	.03	.54	.04	.50
20	.05	.25	.12	.09	.13	.10	.52	.94	.46	.97	.54	.95
20	.10	.10	.08	.11	.07	.12	.03	.62	.02	.63	.03	.60
		.25	.11	.17	.12	.18	.26	.95	.20	.97	.26	.96
	.05	.10	.13	.06	.11	.07	.17	.75	.13	.80	.16	.77
40		.25	.19	.09	.21	.12	.86	.95	.86	.97	.88	.96
40	.10	.10	.12	.12	.11	.13	.09	.79	.07	.81	.08	.79
		.25	.17	.17	.20	.22	.58	.98	.55	.99	.62	.98
	05	.10	.11	.06	.13	.06	.34	.90	.30	.92	.33	.91
70	.05	.25	.18	.10	.25	.12	.97	.98	.97	.99	.97	.98
70	10	.10	.12	.12	.13	.13	.15	.91	.12	.91	.14	.91
	.10	.25	.16	.17	.23	.20	.84	.99	.83	.99	.85	.99

3

4 Table 4

5 *Percentages of aberrance flagged by different statistics in empirical data analysis*

	Aberrance Type	Z_0	Zl	Z_s	Bayesian procedure	Z_m
	All	3.6%	5.0%	5.0%	5.0%	4.9%
Flagged response times	Positive	3.6%	2.8%	2.8%	2.8%	2.8%
	Negative	0%	2.2%	2.2%	2.2%	2.1%
Flagged Examinees	All	3.2%	5.8%	4.5%	4.5%	4.3%

1 Table 5

	Z ₀	Zl	Zs	Bayesian procedure
Z_l	34.8%			
Z_s	11.8%	45.5%		
Bayesian procedure	11.8%	46.9%	88.4%	
Z_m	11.8%	47.5%	89.6%	93.9%

2 Similarity of examinees' flagging with different statistics

3



- 1
- 2 *Figure 1.* Probability of detection (top) and precision of detection (bottom) of five
- 3 statistics across test length and aberrance rates of items



2 *Figure 2.* Probability of detection (top) and precision of detection (bottom) of all statistics

3 across test length and aberrance rates of sample







3 analysis

4

1 Appendix

- 2 Table A1
- 3 The likelihoods of randomly flagging a student at or above different cut levels (fixed number of
- 4 *items*)

Number of Items as the Cut Level										
n	1	2	3	4	5	6	7	10	15	20
20	64.15%	26.42%	7.55%	1.59%	0.26%	0.03%	0.00%	0.00%	0.00%	0.00%
30	78.54%	44.65%	18.78%	6.08%	1.56%	0.33%	0.06%	0.00%	0.00%	0.00%
40	87.15%	60.09%	32.33%	13.81%	4.80%	1.39%	0.34%	0.00%	0.00%	0.00%
50	92.31%	72.06%	45.95%	23.96%	10.36%	3.78%	1.18%	0.02%	0.00%	0.00%
60	95.39%	80.84%	58.26%	35.27%	18.03%	7.87%	2.97%	0.07%	0.00%	0.00%
70	97.24%	87.08%	68.63%	46.61%	27.21%	13.72%	6.04%	0.25%	0.00%	0.00%
80	98.35%	91.39%	76.94%	57.16%	37.11%	21.08%	10.53%	0.65%	0.00%	0.00%
90	99.01%	94.33%	83.36%	66.42%	47.03%	29.48%	16.39%	1.45%	0.00%	0.00%
100	99.41%	96.29%	88.17%	74.22%	56.40%	38.40%	23.40%	2.82%	0.01%	0.00%
120	99.79%	98.45%	94.25%	85.56%	72.18%	55.85%	39.37%	7.86%	0.10%	0.00%

6	Table A1 shows the probability of randomly flagging an individual when the cut
7	increases from 1 to 20 aberrant RTs, for test lengths of 20-120 items. For example, when
8	the test only contains 20 items, an individual with 6 aberrant RTs will have a low false
9	positive rate (0.03%, only 3 students will be randomly flagged in 10,000 students).
10	However, when the test has 70 items, a cut of 6 will have a high false positive rate
11	(13.72%, 1,372 students will be randomly flagged in 10,000 students). By this table, a cut
12	for flagging individuals can be determined after the total number of aberrant RTs for
13	each individual is computed.